

1 **Revision 1**

2 **Analyst and etching protocol effects on the reproducibility of apatite confined fis-**
3 **sion-track length measurement, and ambient-temperature annealing at decadal time**
4 **scales**

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6 Murat T. Tamer¹, Ling Chung², Richard A. Ketcham¹, Andrew J.W. Gleadow ²

7
8 ¹Jackson School of Geosciences, The University of Texas at Austin, 78712 Austin, TX, USA

9 ²School of Earth Sciences, University of Melbourne, 3010 Melbourne, VIC, Australia

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11 **1. Abstract**

12 Previous inter-laboratory experiments on confined fission-track length measure-
13 ments in apatite have consistently reported variation substantially in excess of statistical
14 expectation. There are two primary causes for this variation: (1) differences in laboratory
15 procedures and instrumentation, and (2) personal differences in perception and assess-
16 ment between analysts. In this study, we narrow these elements down to two categories,
17 etching procedure and analyst bias. We assembled a set of eight samples with induced
18 tracks from four apatite varieties, initially irradiated between 2 and 43 years prior to etch-
19 ing. Two mounts were made containing aliquots of each sample to ensure identical etching
20 conditions for all apatites on a mount. We employed two widely used etching protocols,
21 5.0M HNO₃ at 20°C for 20s and 5.5M HNO₃ at 21°C for 20s. Sets of track images were then
22 captured by an automated system and exchanged between two analysts, so that measure-
23 ments could be carried out on the same tracks and etch figures, in the same image data, al-

24 lowing us to isolate and examine the effects of analyst bias. An additional 5 seconds of etch-
25 ing was then used to evaluate etching behavior at track tips. In total, 8391 confined fission-
26 track length measurements were performed; along with 1480 etch figure length measure-
27 ments. When the analysts evaluated each other's track selections within the same images
28 for suitability for measurement, the average rejection rate was ~14%. For tracks judged as
29 suitable by both analysts, measurements of 2D and 3D length, dip, and c-axis angle were in
30 excellent agreement, with slightly less dispersion when using the 5.5M etch. Lengths were
31 shorter in the 5.0M-etched mount than the 5.5M-etched one, which we interpret to be
32 caused by more prevalent under-etching in the former, at least for some apatite composi-
33 tions. After an additional 5s of etching, 5.0M tracks saw greater lengthening and more re-
34 duction in dispersion than 5.5M tracks, additional evidence that they were more likely to be
35 under-etched after the initial etching step. Systematic differences between analysts were
36 minimal, with the main exception being likelihood of observing tracks near perpendicular
37 to the crystallographic c axis, which may reflect different use of transmitted versus reflect-
38 ed light when scanning for tracks. Etch figure measurements were more consistent be-
39 tween analysts for the 5.5M etch, though one apatite variety showed high dispersion for
40 both. Within a given etching protocol, each sample reflected a decrease of mean track
41 length with time since irradiation, giving evidence of 0.2-0.3 μm of annealing over year to
42 decade time scales.

43
44 **Keywords:** Fission Track; Etching Procedure; Step Etching; Ambient temperature; Anneal-
45 ing; Confined Track Length.

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47 °Corresponding author: tamer@jsg.utexas.edu

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49 **2. Introduction**

50 Fission tracks are radiation damage trails in solid materials produced by fission de-
51 cay. Natural, spontaneous fission decay of ^{238}U creates fossil or spontaneous tracks, while
52 thermal-neutron induced fission of ^{235}U in nuclear reactors (Meitner and Frisch 1939) cre-
53 ates induced tracks. In apatite the damage trails from fissioning nuclei initially leave a track
54 with a length of $\sim 21\ \mu\text{m}$ (Bhandari et al. 1971; Jonckheere 2003) and a diameter of $\sim 10\ \text{nm}$
55 (Paul and Fitzgerald 1992). Thermal annealing of the radiation damage leads to gradual
56 repair of the crystal structure as a function of time and temperature (Fleischer et al. 1964)
57 which results in shortening of the tracks. Fission tracks are thermochronometers (Wagner
58 1981); each fission track carries information on the temperatures it has experienced since
59 its formation.

60 Fission tracks become observable under optical microscopes after being enlarged by
61 a suitable etching protocol. Etching of a polished mineral surface reveals tracks intersecting
62 that surface, and the etchant penetrates into confined fission tracks below the surface
63 through cracks and cleavages (TINCLE) or other surface-intersecting host tracks (TINT)
64 (Bhandari et al. 1971). In any particular sample, the confined track lengths vary due to non-
65 identical etching duration of the individual tracks (Green et al. 1986), crystallographic ani-
66 sotropy (Green and Durrani 1977; Watt et al. 1984; Donelick et al. 1999), the stochastic na-
67 ture of nuclear splitting and particle interactions (e.g. Zeigler et al., 2008), and varying de-
68 grees of annealing during the thermal history of the host rock. Over geological time scales,
69 in most apatites fossil tracks are erased above 120°C (Naeser 1981), partially annealed

70 above 60°C (Gleadow and Duddy, 1981; Wagner et al. 1989) and subject to slow annealing
71 at <60°C (Gleadow and Duddy 1981; Donelick et al. 1990; Spiegel et al. 2007). The track
72 length distributions reflect the temperature history of the apatite since it last cooled into
73 the ~60-120 °C window, the so-called Partial Annealing Zone (Gleadow et al. 1986). Apatite
74 fission-track modeling uses the information from individual track length measurements
75 from a sample to reconstruct the time and temperature conditions that the sample has un-
76 dergone (Green et al. 1989; Gallagher 2012; Ketcham 2005). No other geo-
77 thermochronometer provides a comparable level of detail. However, to be a reliable tool
78 for reconstructing thermal histories, length measurements need to be robust and reproduc-
79 ible within and among laboratory groups (Ketcham et al. 2009, 2015, 2018).

80

81 *2.1 Confined track-length revelation*

82 Fission-track analysis requires the use of optical microscopes, and therefore any fea-
83 ture we observe must be etched. This makes the etching procedure a crucially important
84 part of any fission track study. An etching procedure has three elements, etchant concen-
85 tration, duration, and temperature, which to some degree can be traded off against each
86 other to achieve roughly equivalent results. Since the advent of fission-track dating, track
87 etching has been understood primarily in terms of a fast etching velocity along the track
88 (v_T) and a slower etching velocity in the bulk mineral (v_B). Standard calculations of etching
89 efficiency (i.e. the fraction of tracks crossing a surface that are revealed by etching) assume
90 these two rates are constant (Fleischer et al. 1964). Under this model, a fully etched con-
91 fined track was defined as spanning the full extent of the line segment with v_T and a small
92 to negligible amount of the v_B region (Laslett et al. 1984), while tracks that do not extend to

93 the ends of the v_T region are under-etched and tracks extending significantly into the v_B re-
94 gion are over-etched.

95 How do we know when we etch too little, too much, or just enough? Early analysts
96 defined optimal etching conditions using consecutive step etch experiments (e.g., Watt and
97 Durrani 1985; Laslett et al. 1984; Green et al. 1986; Carlson et al. 1999), where confined
98 track length measurements were performed between short-duration etching steps. As
99 summarized by Jonckheere et al. (2017, their Fig. 1) the pattern observed in most of these
100 experiments is that mean confined lengths would rise quickly and then reach a near-
101 plateau value, after which they would rise slowly or not at all with further etching. Laslett
102 et al. (1984) proposed that the onset of this plateau or linear slow lengthening defines
103 where most revealed tracks are fully etched or slightly over-etched.

104 However, Jonckheere et al. (2017) show that a constant- v_T line segment model is
105 oversimplified. By conducting step-etching experiments using an image-capture system
106 that allowed them to follow the evolution of individual tracks rather than measuring a ran-
107 dom sample after each step, they demonstrated that track etching velocity changes along
108 the length of the track, decreasing continuously as the ends are approached. Importantly,
109 they also showed that the region of enhanced etching in spontaneous and unannealed in-
110 duced tracks in Durango apatite extends considerably beyond their conventionally accept-
111 ed lengths (Jonckheere et al. 2017).

112

113 *2.2 Reproducibility of confined track length and etch figure measurements.*

114 A series of studies has revealed an unexpectedly and persistently poor level of re-
115 producibility in confined track length measurements for both spontaneous and induced

116 tracks at a range of annealing levels (Miller et al. 1990; Barbarand et al. 2003b; Ketcham et
117 al. 2009, 2015, 2018), as well as for etch figure diameters (D_{par}) (Sobel and Seward, 2010;
118 Ketcham et al., 2015, 2018). Variation between measurements from different laboratories
119 consistently exceeds statistical expectation, even when they use the same etching proce-
120 dures. These disparities could result from a mixture of several factors, such as variation in
121 etching time or temperature; inexact etchant concentration; different types of microscopes,
122 lens configurations, and light sources; analyst biases in finding and selecting tracks as suit-
123 able for measurement; and length measurement procedures. Because the measurement
124 process is very analyst-dependent, tracking down which of these factors is dominant, and
125 thus the best candidate for community-wide improvement, is not straightforward. In this
126 study, we narrow down this set of problems to the final stages of the analysis process, in
127 which tracks are etched, identified, evaluated for measurement, and measured, by having
128 two analysts measure the same individual tracks and etch figures in a range of samples
129 etched with two protocols.

130

131 *2.3 Low-temperature annealing at laboratory time scales*

132 It has been reported that induced fission tracks experience shortening at ambient
133 temperatures on time scales from minutes to months in various apatites (Donelick et al.
134 1990; Belton 2006; Tamer and Ketcham 2018). If significant annealing of freshly formed
135 induced tracks does occur during the months to decades after irradiation, then this may be
136 another factor causing variation in measurements of standard materials. This phenomenon
137 may also cloud the meaning of the “unannealed” length used to normalize all track lengths
138 for annealing modeling (Laslett and Galbraith 1996; Ketcham 2019).

139 This short-time-scale annealing may reflect the same process responsible for spon-
140 taneous tracks that have only experienced low temperatures over geological time scales
141 being typically $\sim 1\text{-}2\ \mu\text{m}$ shorter than induced tracks (Ketcham 2019), or it may reflect a
142 different process. Expanding the experimental database for this phenomenon should help
143 shed light on its cause.

144

145 *2.4 Aim of this study*

146 In this study, we conduct a series of experiments to address the problems of length
147 measurement reproducibility and low-temperature annealing. Taking a selection of apa-
148 tites that have experienced ambient-temperature annealing of induced tracks for as many
149 as 36 years, we attempt to isolate the causes of variation by having two experienced ana-
150 lysists measure two aliquots of each, etched with different protocols. We isolate user-specific
151 sources of variation by taking advantage of image-capture software to ensure that each an-
152 alyst is observing the same tracks in the same way. The image-capture system also enabled
153 us to conduct a follow-on step-etch analysis to help discern the nature of etching rate varia-
154 tion near track tips.

155 This work explores four main points: 1- How much agreement do two analysts have
156 on a single track-length or etch-figure measurement? 2- What is the difference between
157 two major etching protocols? 3- What is “under-etching”, and can we recognize it based
158 solely on the appearance of etched tracks? 4- Do induced tracks anneal at low temperatures
159 on time scales from years to decades?

160

161 **3. Experimental Details**

162 Figure 1 summarizes the organization of the experiment. Eight apatite samples with
163 induced tracks were selected, including three Durango, two Mud Tank and two Renfrew
164 apatites, and one sample from a population-method-dated granite from King Island, Bass
165 Strait, Australia (Gleadow and Lovering, 1978), which were irradiated from ~2 to ~43
166 years prior to etching. Sample details are summarized in Table 1. Two epoxy grain mounts
167 were prepared for each sample (Fig. 1A, first row). Procedures and devices used in sample
168 preparation followed those described in Gleadow et al. (2015). After polishing, ^{252}Cf irradi-
169 ation (Donelick and Miller 1991) was carried out to increase the number of measurable
170 confined tracks. To ensure identical etching conditions, two super-mounts were prepared
171 by separately affixing the two grain mounts for each apatite sample to two petrographic
172 slides (Fig. 1A, second row). One super-mount was etched using 5.0M HNO_3 at 20°C for 20s
173 (Gleadow et al. 1986), and the other with 5.5M HNO_3 at 21°C for 20s (Carlson et al. 1999)
174 (Fig. 1A, third row); for simplicity, hereafter these are referred to as 5.0M and 5.5M, respec-
175 tively. Etching followed procedures described by Donelick et al. (2005).

176 Grain images were acquired at 1000x magnification on a Zeiss M1m Axio-Imager
177 microscope operating under TrackWorks control software at the University of Melbourne
178 (Gleadow et al. 2015). Transmitted and reflected light image stacks, with depth step sizes of
179 0.3 μm for the 5M mount and 0.2 μm for the 5.5M mount, each covering a depth of ~6-7 μm
180 of selected c-axis-horizontal grains, were captured automatically (Gleadow et al. 2009).
181 Measurements on captured digital image sets at an ~8000x effective magnification were
182 performed by two analysts, An1 and An2, each with ~10 years of experience in fission-
183 track analysis. Each analyst had a copy of all of the image sets and processed them inde-
184 pendently in their home laboratories using FastTracks V3 image processing software. Pa-

185 parameters determined manually on the image sets included c-axis directions for each grain,
186 >100 3D confined track lengths (azimuth (2D) angle to c-axis, dip and true (3D) angle to c-
187 axis were calculated automatically) and >40 Dpar values (from both induced and Cf-
188 irradiation tracks) per sample. Location and measurement data were saved in XML-format
189 files. The FastTracks software displays the data as overlays on the image stacks, and allows
190 the visibility of recorded features to be turned off and on individually.

191 To assess the reproducibility of the measurements, two sets of data were acquired.
192 In Set 1, lengths from the 5.0M mount were selected, imaged, and measured by An1 and
193 lengths from the 5.5M mount were selected, imaged and measured by An2. The respective
194 XML files were then given to the non-selecting analyst, who viewed the measurements with
195 the numerical data layers turned off, leaving only markers of where the measurements
196 were taken (Fig. 1B, second row). The second analyst then re-measured the selected fea-
197 tures. Any length selected by one analyst, but assessed as inappropriate or non-measurable
198 by the other, was excluded from the final results. To test for operator differences in track
199 selection, in Set 2 the mounts were switched, with An1 locating and measuring tracks in
200 different areas of the 5.5M mount, and An2 doing the same for the 5.0M mount. For Set 2,
201 the non-choosing analyst did not repeat the measurements. Length distributions obtained
202 from all measurements were used to evaluate and compare the length selection criteria (or
203 identification pattern) of each analyst.

204 To help evaluate the effects on length measurements of changing etching conditions
205 and etching rates near the track tips, the 5M and 5.5M mounts were then etched for an ad-
206 ditional 5 seconds at their respective acid concentration and temperature. All tracks meas-
207 ured in Set 1 for selected samples were then re-imaged and re-measured. After this addi-

208 tional etching step, no “new” track was added to the population; only tracks measured after
209 the first etching step were re-measured. Those tracks that could not be measured after fur-
210 ther etching, due to their ends overlapping with neighboring features and those that could
211 no longer be identified as confined fission-tracks, were excluded.

212

213 **4. Results**

214 In total, 8391 confined fission-track length measurements were performed, along
215 with 1480 etch figure diameter measurements. For Set 1, 3100 tracks were found by the
216 analysts that first examined each mount; of these, 422 were rejected by the other analyst,
217 an average rejection rate of 14%. Statistics for Set 1 include 2678 confined track lengths
218 (Tables 2 and 3) and 740 etch figures (Table 4), all measured by both analysts. In Set 2, 921
219 confined track lengths were selected and measured by An1 and 895 by An2, independently
220 from each other’s measurements (Table 5). Details of 788 confined length measurements
221 from one sample each of the three major apatite species (Durango, Renfrew and Mud Tank)
222 etched for an additional 5s and re-imaged are in Table 6.

223

224 *4.1 Measurement comparison at the individual track level*

225 Track length results for measurement Set 1 are provided in Table 2, and differences
226 in measurements between analysts calculated on a track-by-track basis are reported in Ta-
227 ble 3. Figure 2 shows comparisons of length (A,B), azimuth (C,D) and dip angle values (E,F)
228 of the same individual tracks measured by the two analysts with the two etching protocols.
229 Track lengths from 5.5M etching (Figure 2A) are longer and slightly more consistent be-
230 tween analysts than observed with the 5.0M protocol (Figure 2B). Notably, results for both

231 analysts feature multiple track lengths below 14 μm for the 5.0M etchant in most samples,
232 whereas with the 5.5M protocol there are only a few tracks measured under 14 μm . Results
233 for both etching protocols feature a high level of agreement between the analysts for track
234 azimuth (Fig. 2C, D), although there is a slightly higher level of dispersion in the 5.0M data.
235 Dip angles are also slightly more dispersed in the 5.0M data (Fig. 2E, F), although part of
236 the discrepancy stems from An1 finding more high-dip tracks than An2 in the initial selec-
237 tion process. Low dip angles are limited to particular values due to the depth intervals be-
238 ing restricted to specific planes in the image stacks, as detailed by Li et al. (2018).

239 Table 3 reveals no evidence of a systematic difference in length or dip measure-
240 ments between analysts; mean differences are small and equally likely to be positive or
241 negative. The standard deviations of the differences are virtually all lower in measure-
242 ments from the 5.5M-etched mount, indicating a higher level of agreement. The sole excep-
243 tions are the 3D length and dip of sample 12, which are probably correlated.

244 Because 3D lengths are influenced by dip, we compare 3D length difference with dip
245 difference in Figure 3. The dispersion for the 5.0M data in Figure 3A is less compact
246 ($R^2=0.021$) but also less correlated than in Figure 3B ($R^2=0.085$). The slight correlation in
247 the latter indicates that a non-negligible component of length dispersion is due to dip dis-
248 persion, while the weaker correlation in the former suggests that other sources of disper-
249 sion are more influential.

250 Results from each analyst measuring the same set of etch figures in each sample are
251 provided in Table 4 and Figure 4. For most samples, An1 and An2 generally agree at low
252 Dpar values, but as Dpar increases An1 tends to get longer Dpar values. The extent of devia-

253 tion is greater for the 5.0M etch than the 5.5M, although Sample 8 shows considerable vari-
254 ability in both etching protocols.

255

256 *4.2 Track selection / rejection / angular bias*

257 Following the unexpected difference between confined track lengths for the two
258 etching protocols shown in Figure 2A and 2B, we tried to ascertain whether an operator
259 bias could be partially responsible. Due to our use of an image capture system, we were
260 able to focus on the differences in measurements at the individual track level, a scale not
261 possible in previous studies. As documented by the difference in numbers of tracks found
262 and measured by the first analyst to analyze a mount (N_{init}) and the number accepted by
263 the second analyst (N_{acc}), on average ~14% of the tracks selected by one analyst were not
264 accepted by the other for measurement (Table 2). Disagreements were primarily due to
265 perception of an indistinct or obscured track end, or intersection of a track end with the
266 polished and etched surface, and were probably influenced by choice of observation mode.

267 Figure 5 shows examples of reflected and transmitted light images of confined
268 tracks selected and measured by An1 and rejected by An2, while Figure 6 shows rejections
269 by An1 of tracks found and measured by An2. Disagreements primarily concern the ap-
270 pearance of track ends that are near the borderline of resolvability. The results probably
271 reflect the respective length observation and measuring strategies of the two analysts. An1
272 uses both reflected and transmitted light to locate and measure tracks, whereas An2 uses
273 transmitted light only. Nonetheless, the selection criteria were sufficiently similar that the
274 great majority (86%) of tracks were judged to be acceptable by both analysts.

275 The effects of track rejection on overall length determinations were varied. Except
276 for two of the four Mud Tank apatite analyses, the rejected lengths were on average shorter
277 than the accepted ones, but often not by very much. With the 5.5M etch, the mean length of
278 rejected tracks was within two standard errors of the accepted tracks for all samples ex-
279 cept the King Island apatite. Conversely, the 5.0M etch of samples 7, 8 and 12 featured
280 mean rejected lengths that were more than two standard errors shorter than the accepted
281 lengths, and samples 9 and 10 are at the edge of the 2-SE limit. However, even in the most
282 egregious cases, removal of the rejected tracks changed the mean track length by at most
283 0.12 μm .

284 The relative frequency of confined track orientations relative to the c-axis found by
285 each analyst is shown in Figure 7. There is no obvious difference at lower angles, but above
286 $\sim 85^\circ$, where track ends become difficult to distinguish (Fig. 6C,D) and under-etching is
287 harder to evaluate, An2 selected them at almost twice the rate as An1. It is not clear, how-
288 ever, whether this is due to different etching (e.g., Jonckheere et al. 2019), different opera-
289 tor tendencies in using transmitted versus reflected light when scanning the grain mount,
290 or other analyst biases pertaining to these challenging tracks.

291 Our Set 2 measurements were intended to test whether the discrepancy between
292 5.0M and 5.5M may have been due to an analyst selection bias. Figure 8A shows the length
293 distributions for Sample 1 in measurement Set 1, in which An1 selected the 5.0M tracks and
294 An2 the 5.5M tracks. In measurement Set 2, An1 selected and measured new tracks in the
295 5.5M mount and An2 in the 5.0M mount (Fig. 1, Table 5). The length distributions, shown in
296 Figure 8B, show the same overall pattern as in Figure 8A: regardless of the analyst making
297 the selection, measurements with the 5.0M protocol feature a higher standard deviation

298 and lower mean track length than with 5.5M. The results clearly show that the differences
299 observed relate to the etching protocol, and not the analyst.

300

301 *4.3 Track lengthening after additional etching*

302 In our next effort to understand the discrepancy in track lengths between the 5.0M
303 and 5.5M protocols, we etched each mount for another 5s to study etching rates near the
304 track tips, and test whether the short tracks observed in Figure 2A were under-etched. On-
305 ly samples 3, 4, and 10, which showed the greatest number of sub-14- μm tracks in the 5.0M
306 etch, were re-measured. The effect of the longer etch times on track appearance are shown
307 in Figure 9. Tracks become longer and thicker with increasing etching time in both cases. At
308 25 seconds the track ends become relatively more distinct and less ambiguous in both apa-
309 tites with both light sources, which in turn led to less dispersed measurements, as shown in
310 Table 6.

311 Figure 10 compares the individual track lengths at 20s and 25s from both etching
312 protocols in samples 3, 4 and 10. In all three cases the 5.0M re-etch shows a significantly
313 greater increase in length compared to 5.5M, especially among shorter tracks. The same
314 trend can be seen in 20s and 25s histogram plots of sample 3 (Figure 11). At the same time,
315 Figure 10 also makes it evident that shorter tracks were likely to be lengthened slightly
316 more even with the 5.5M etch. Summary statistics for these experiments are plotted in Fig-
317 ure 12. Standard deviation falls substantially for the 5.0M and slightly for 5.5M after re-
318 etching, although the 5.0M data remain more dispersed than the 20s 5.5M data. Mean track
319 length increases for all samples, but more for the 5.0M etch ($\sim 0.7 \mu\text{m}$ on average) for each
320 sample than the corresponding 5.5M etch ($\sim 0.4 \mu\text{m}$). The greatest increase in length and

321 decrease in standard deviation occurs for the Renfrew apatite, Sample 3, after the 5.0M re-
322 etching, suggesting this sample was the most under-etched after 20s. Notably this apatite
323 has the lowest bulk etching rate of all the samples (see Dpar in Table 4) in this study due to
324 its near end-member fluorapatite composition. The extra five seconds of etching resulted in
325 all 5.0M mean track lengths exceeding the 20s 5.5M data

326

327 *4.4 Ambient temperature annealing on year-to-decade time scales*

328 Ambient temperature annealing over year to decade time scales is reflected in the
329 mean induced track lengths in Figure 13. Data from both analysts and both 20s etching pro-
330 tocols show a mean track length decrease with increasing storage time at ambient temper-
331 ature in all three apatites studied. Overall, the 5.5M data show clearer evidence of a signifi-
332 cant change, and there is apparent variation in the behavior of the different apatites. Du-
333 rango apatite, which features the largest time difference, shows significant annealing be-
334 tween 3.5 and 27 years, but not between 27 and 32, while Renfrew and Mud Tank apatites
335 show some evidence of annealing between 27 and 32 or 36 years, respectively. These sam-
336 ples were stored in a temperature-controlled building where ambient temperature varia-
337 tions are mostly in the range 20 ± 3 °C.

338

339 **5. Discussion**

340 We next consider our results in the context of our original four questions.

341

342 *5.1 Agreement between analysts*

343 One surprising result of our study was the extent to which one analyst rejected
344 tracks selected by the other (~14%). These varying decisions are partly due to different
345 emphases placed on transmitted versus reflected light observation, slight differences in
346 personal criteria based on their previous experience in fission track measurement, and
347 their respective “visual memory” based on tracks previously measured. There is also some
348 degree of variable decision-making over time, as first documented by Barbarand et al.
349 (2003); follow-up inspection of a rejected track frequently (roughly 50% of the time) re-
350 sulted in the initial analyst recognizing and agreeing with the reason for rejection. Com-
351 bined, these results indicate that utilizing image capture for fission-track analysis, and in-
352 cluding some kind of verification step (i.e. re-evaluation by the same or a different analyst)
353 can increase data quality.

354 Rejected tracks were on average slightly shorter than non-rejected ones. The magni-
355 tude of disagreement was larger for the 5.0M etch, and the 5.5M-etched sample with the
356 largest disagreement was King Island, which has the smallest etch figures. Our interpreta-
357 tion is thus that 5.0M and King Island tracks were more likely to be rejected due to indis-
358 tinct, poorly etched ends, which may reflect under-etching, while the other rejections in-
359 cluded a larger share of semi-observed track ends, which would have a less systematic ef-
360 fect on lengths.

361 The degree of difference between the two analysts is small compared to the total
362 number of tracks accepted by both (~86%). When both analysts agreed that a confined
363 track was valid, agreement between their measurements was excellent (Figure 2, Table 3).
364 The slightly larger extent of disagreement in the 5.0M compared to the 5.5M confined
365 length data (Fig. 2A, B) likely resulted from track ends being on average somewhat less

366 clearly revealed. Azimuth angle data were extremely repeatable (Fig. 2C, D). Dip angles
367 were less so (Fig. 2E, F), probably due to variation in determining the best image plane in
368 which the track tips are in focus. Interestingly, however, the disagreements are roughly
369 symmetrical, showing no strong evidence of a bias in dip measurement due to different
370 techniques. The effect of dip disagreements on 3D length is noticeable in the 5.5M data but
371 not in the 5.0M (Fig. 3), even though the 5.0M data included more steeply dipping tracks for
372 which a given change in dip would have a larger effect on length. We interpret this to mean
373 that unclear track tips exert a larger effect on measurements than dip uncertainties.

374 The light source used when scanning for confined tracks may affect the number of
375 measured tracks at certain angles to the c axis (Fig. 6C, D; Fig. 7). Given that the track densi-
376 ties of these samples were quite high and they were not subjected to high temperature an-
377 nealing, analysts identified the target number of confined tracks (~200) with ease. The ac-
378 tual angular bias may be higher or lower with a higher “required” number of tracks or less
379 track availability. Possible causes for bias could include a tendency to bypass tracks with
380 ends that are possible but challenging to distinguish, or conversely a desire to attempt to
381 include tracks from all angles.

382 Our Dpar data show evidence of both slight analyst bias and dispersion (Fig. 4, Table
383 4). Measurements by An1 tended to be slightly longer than An2, averaging about 0.1 μm ,
384 with both etches. The 5.5M etch decreased the difference between analysts for three apa-
385 tite varieties. Interestingly, however, the apatite with the largest etch figures, Mud Tank,
386 also featured the largest dispersion, which was not alleviated with the stronger etch. The
387 reason behind this is not clear, although one possibility is zoning in OH content, which af-
388 fects etch figure size and would be difficult to detect with electron microprobe analysis.

389 We also note that two apatites, Renfrew and King Island, have etch figures that av-
390 erage 1.5 μm or below with the 5.5M protocol, placing them outside the range observed by
391 Carlson et al. (1999) and underlying the annealing models based on those data (Ketcham et
392 al. 1999). In the Carlson et al. (1999) data set, Renfrew apatite had the second-smallest
393 Dpar value reported ($1.65\pm 0.03 \mu\text{m}$). The lower values reported here, averaging 1.49 ± 0.02
394 μm , may partially reflect the different measurement systems used, though our mean values
395 for Durango apatite, $1.78\pm 0.02 \mu\text{m}$ versus $1.83\pm 0.02 \mu\text{m}$ in Carlson et al. (1999) are much
396 more comparable, although differing in the same sense. Taking these reference points, the
397 yet lower Dpar value we observe for King Island, $1.40\pm 0.02 \mu\text{m}$, is well-supported evidence
398 of natural Dpar values falling outside the calibrated range. The dispersion, bias and range
399 of Dpar values reported here provides further evidence of the need for caution in using
400 them for thermal history analysis (Ketcham et al. 2018).

401

402 *5.2 Difference between two major etching protocols.*

403 Our data show multiple indications that the 5.0M, 20°C, 20s etching protocol result-
404 ed in some degree of under-etching. Both analysts show broader track-length distributions
405 with the 5.0M etch (Figure 2A, B and Figure 3), and slightly worse agreement on individual
406 track lengths, dip angles (Figure 2E, F) and Dpar measurements (Figure 4). Similarly, the
407 additional 5s etching step provided a greater increase in lengths, especially on initially
408 short tracks (Figure 10), narrower histograms (Figure 11), and greater reduction in stand-
409 ard deviation (Figure 12) at 5.0M than with 5.5M. Altogether, these results imply that after
410 20s some tracks still had a region of somewhat enhanced track etching rate beyond their
411 tips. In fact, the thickness of the point clouds for the 5.5M etch in Figure 10, reflecting

412 length increases ranging from ~ 0.1 - $1 \mu\text{m}$, implies that some 5.5M tracks were also under-
413 etched, though with less frequency and severity.

414 It is possible that there was some problem with etching conditions for one or both of
415 our mounts, such as the etchant concentration or temperature, although we followed our
416 usual procedures with particular care and consider this extremely unlikely. We note that
417 our mean track lengths are well within the range reported by Ketcham et al. (2015), even
418 by very experienced and active analysts.

419 It should also be noted that the temperature used for our 5.0M protocol, 20°C , while
420 employed for a number of classic studies (e.g., Gleadow et al. 1986) and data sets (Green et
421 al. 1986; Barbarand et al. 2003b), seems to have drifted out of current practice. In the inter-
422 laboratory study reported by Ketcham et al. (2015), nine different lab groups provided data
423 in which they used 5.0M HNO_3 , but at temperatures from 21°C to 24°C ; none reported using
424 20°C . While temperature was carefully controlled in the present study, it is probable that
425 some or all of these reported values reflect ambient etchant temperatures in the laboratory
426 at the time, rather than controlled conditions.

427 Increasing etching temperature and/or concentration would be expected to in-
428 crease etching rate and thus reduce the occurrence of under-etching. However, the data re-
429 ported by Ketcham et al. (2015) do not show clear evidence of a systematic difference in
430 mean track lengths with etching temperature at a given etchant strength, or between 5.0M
431 and 5.5M results, across laboratories. This implies that factors aside from etchant protocol,
432 such as analyst training, are also important for length measurements and their reproduci-
433 bility. However, by effectively controlling for analyst-specific variation, this study demon-

434 strates that subtle changes in etching conditions can have large effects on mean track-
435 length measurements.

436

437 *5.3 Can under-etching be evaluated reliably?*

438 If some tracks etched with the 5.0M protocol were under-etched by more than 1 μm ,
439 were they improperly accepted for measurement? Although in some cases (illustrated in
440 Fig. 5, 6, and 9) the ability to locate track ends reliably was debatable, leading to disagree-
441 ment between the analysts, re-inspection of the image data for the overwhelming majority
442 of sub-14- μm tracks accepted by both analysts did not change either analyst's mind about
443 their appropriateness for measurement. According to each analyst's training and experi-
444 ence, they were valid confined tracks. The Set 2 data, in which the opposite analyst identi-
445 fied the tracks for each etch (Fig. 8), corroborates this conclusion.

446 We propose that the difficulty in evaluating under-etching is caused by the gradual,
447 rather than sudden, diminishing of etching velocity along the track as its ends are ap-
448 proached (Fleischer et al., 1969; Jonckheere et al., 2017). If we call this velocity $v_T(x)$, with x
449 denoting the distance along the track from its center to one end, then as the end is ap-
450 proached $v_T(x)$ becomes closer to, but still higher than, the bulk etching velocity (v_B) (Fig-
451 ure 14). As this occurs, the disparity between bulk and along-track etching may diminish
452 sufficiently that the track tip can start to widen, making it easier to see and thus measure.
453 This scheme maintains the original definition of "under-etched" as leaving some region
454 where $v_T(x) > v_B$ unetched, although it may be unclear how different their values need to be
455 to define the end of a given track.

456 Such an under-etching effect may be one of the mechanisms underlying the poor re-
457 producibility of confined length data, either because the under-etching is undetected, or
458 because analysts are more likely to disagree about track suitability. Tracks etched even for
459 only 10 and 15s (Tamer 2012) can demonstrate reasonable/noticeable track ends, despite
460 being under-etched. Taking the observation of track ends into account, it is not clear how to
461 define a quantitative criterion to decide if a track is under-etched. Track thickness, the
462 proximity to the crystal surface, and the number of intersecting tracks all play a role in the
463 complex track-etching problem, which needs to be addressed in future experiments.

464 The issue of under-etching is not a trivial one. Track lengths are used to infer ther-
465 mal histories (Ketcham et al. 2007; Gallagher 2012) and a shorter length implies more time
466 spent at higher temperature. If a sufficient number of under-etched tracks are included in
467 the measurement, or for that matter in the original annealing databases underlying the an-
468 nealing models, the thermal history may be distorted. Furthermore, because there is no sta-
469 tistical test for over-dispersion of lengths as there is for ages, such a problem is likely to go
470 undetected.

471 It may thus be worth re-evaluating whether the method by which an optimal etching
472 protocol has been defined using step etching (Laslett et al. 1984, etc.) is overly conservative
473 in trying to prevent over-etching, rather than minimize under-etching. By halting the etch
474 immediately upon reaching the plateau mean track-length value, we may be effectively
475 “setting up camp on the edge of a cliff,” where a small change in etching conditions, or apa-
476 tite composition or solubility, can have a large effect on the degree of etching and track ap-
477 pearance. In contrast, over-etching at the low v_B rate will only have a small effect on con-
478 fined track lengths. However, further data are needed on whether and how this effect ex-

479 tends to spontaneous tracks (e.g., Jonckheere et al., 2017), or tracks with a greater degree
480 of annealing.

481 It should also be remembered that new confined tracks are intersected continuously
482 as surface-intersecting tracks widen with increasing etching at depth, and in fact the con-
483 fined track revelation rate increases with etching time (Jonckheere et al., 2007). As a result,
484 the presence of some under-etched tracks is unavoidable. There were under-etched tracks
485 with both etching protocols in this study, as shown by the re-evaluation exercise (Fig. 5, 6).
486 What will evolve with progressive etching is the relative number of under-etched tracks
487 versus fully or over-etched ones.

488

489 *5.4 Low-temperature annealing at year to decade time scales*

490 The difference in mean track length versus time since irradiation provides intri-
491 guing evidence of track annealing at ambient temperatures over year to decade time scales.
492 The fact that the differences are larger in the 5.5M data is probably traceable to the reduc-
493 tion of under-etching seen in the 5.0M data, increasing the clarity in the underlying signal.
494 Our experimental design rules out these differences being due to variation in etching,
495 measurement system, or analyst. However, we cannot rule out that there may be subtle dif-
496 ferences in the different samples used of each apatite variety, irradiated at these separate
497 times, that are responsible for the observed length variation. The fact that the trend is simi-
498 lar in all three, however, lends confidence to the interpretation that they represent a true
499 annealing effect. Distinguishing whether the differences in apparent annealing rates are
500 due to variation within the apatites, or variable annealing behavior between them, will re-
501 quire more data.

502 In Durango apatite, the mean length decrease between 2.6 and 27 years, on the or-
503 der of 0.2-0.3 μm , substantially exceeds the predicted amount; the Ketcham et al. (1999)
504 curvilinear annealing model predicts length reduction of $\sim 0.03 \mu\text{m}$, an order of magnitude
505 less than we observe here. This may be due to the annealing model being based entirely on
506 high-temperature annealing experiments (150°C and above), reducing its ability to capture
507 annealing in this region of time-temperature space. It may be possible to combine these da-
508 ta with the Carlson et al. (1999) data set to improve the annealing model, but this would
509 require a reconsideration of how much time can pass after irradiation to define an “initial”
510 track length.

511 Other studies have also suggested that some possibly non-thermal reconstruction of
512 the crystal lattice in apatite may take place at low temperature over short durations from
513 minutes to days (Donelick et al. 1990; Belton, 2006). Further insight into early-stage fission
514 track annealing may be obtained by searching for possible effects at high temperatures at
515 very short time scales (e.g. Murakami et al. 2006), or at lower ambient temperature condi-
516 tions ($>0^\circ\text{C}$) at long time scales (Gleadow and Duddy 1981; Spiegel et al 2007).

517

518 **6. Implications**

519 Our results shed considerable light on the factors underlying the suboptimal repro-
520 ducibility of fission-track length measurements documented in previous studies. When two
521 operators observe the same well-etched confined fission track, their results are highly con-
522 sistent (Table 3). As tracks ends become less distinct due to a lower degree of etching,
523 measurement consistency diminishes somewhat, and eventually disagreements arise as to
524 whether a track is fully etched or not. Many of these disagreements can be resolved, and

525 measurement consistency improved, by utilizing an image capture system and including a
526 re-evaluation step in analysis protocols.

527 An unexpected finding is that, even prior to this point of disputed appropriateness
528 for measurement, confined tracks can be substantially under-etched by over 2 μm com-
529 pared to near-full-extent of the region of enhanced etchability defining the latent track. By
530 carefully controlling for analytical effects due to instrumentation and analyst bias, we have
531 demonstrated significant and potentially influential differences between two of the princi-
532 pal etching protocols that have been employed for apatite fission-track analysis. The proto-
533 col using 5.0M HNO_3 at 20°C for 20s appears to be more susceptible to a slight and some-
534 times significant degree of under-etching. Moreover, this under-etching is not easily de-
535 tectable under standard optical microscope observation.

536 Under-etching, combined with analyst-varying criteria for what constitutes a well-
537 etched track end, may account for a significant component of the poor reproducibility in
538 track length measurements. It is clear that the definition of under-etching needs to evolve,
539 accounting for the variability in etch rates as track tips are approached. The community has
540 not fully explored how apatite fission-track etching starts, progresses and stops in a given
541 etching protocol, and how it is affected by varying apatite solubility. Track etching veloci-
542 ties and bulk etching velocities must be established to figure out when tracks are fully
543 etched in a step etching protocol to understand the etching characteristics in a more com-
544 plete way.

545 If sufficiently pervasive, under-etching will affect thermal history inverse modeling,
546 biasing results toward higher temperatures to replicate the apparent increased degree of

547 annealing. It is likely that under-etching has a direct and deleterious effect on the reproduc-
548 ibility of such modeling (Ketcham et al., 2018).

549 We have also documented evidence for ambient temperature annealing of induced
550 tracks at year to decade time scales in multiple apatites over times up to 36 years, an ob-
551 servation not predicted by annealing models based exclusively on high-temperature exper-
552 iments. This finding supports previous studies (Donelick et al. 1990; Belton 2006) in imply-
553 ing that our conception of the initial confined track length should evolve to account for time
554 since irradiation (e.g., Laslett and Galbraith, 1996). Combining ambient temperature an-
555 nealing data with higher-temperature annealing data sets (Carlson et al. 1999; Barbarand
556 et al. 2003b) may also improve apatite fission track thermal history modeling.

557

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563

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Table 1: Apatites used in this study, neutron irradiation dates and ages of induced tracks.

| Apatite | Composition (apfu) ¹ | | | Irradiation Location | Sample Number | Irradiation Date | Track Age (years) ⁴ | Track Age (ln(s)) |
|-------------|---------------------------------|-------------------|-------------------|----------------------|---------------|------------------|--------------------------------|-------------------|
| | F | Cl | OH | | | | | |
| Durango | 1.81 ² | 0.13 ² | 0.07 ² | Melbourne | 1 | 2/20/1985 | 32.11 | 20.74 |
| | | | | Melbourne | 7 | 3/8/1990 | 27.07 | 20.56 |
| | | | | Austin | 10 | 7/30/2014 | 2.65 | 18.24 |
| Mud Tank | 1.30 ³ | 0.03 ³ | 0.67 ³ | Melbourne | 4 | 3/25/1981 | 36.02 | 20.85 |
| | | | | Melbourne | 8 | 3/8/1990 | 27.07 | 20.56 |
| Renfrew | 1.95 ² | 0.01 ² | 0.04 ² | Melbourne | 3 | 2/20/1985 | 32.11 | 20.74 |
| | | | | Melbourne | 9 | 3/8/1990 | 27.07 | 20.56 |
| King Island | 1.99 ³ | 0.01 ³ | 0.00 ³ | Melbourne | 12 | 11/26/1973 | 43.36 | 21.04 |

¹ Stoichiometry calculations from Ketcham (2015).

² Composition data from Carlson et al. (1999).

³ Composition data from University of Melbourne, using Cameca SX50 electron microprobe (settings: accelerating voltage = 15 kV; beam current = 35 nA; beam spot size = 10 μm).

⁴ All samples initially etched on 3/25/2017.

Table 2: Set 1 confined track length measurements.

| Apatite | Sample | Initial Measurements ¹ | | | Rejected Measurements ² | | | | Accepted Measurements ³ | | | | |
|-------------|--------|-----------------------------------|-----------|------------|------------------------------------|--------------------|-----------|------------|------------------------------------|-----------|------------|-----------|------------|
| | | N | MTL (μm) | StDev (μm) | N | Rejection Rate (%) | MTL (μm) | StDev (μm) | N | Analyst 1 | | Analyst 2 | |
| | | | | | | | | | | MTL (μm) | StDev (μm) | MTL (μm) | StDev (μm) |
| | | <i>5.0M etch⁴</i> | | | | | | | | | | | |
| Durango | 1 | 212 | 15.52(07) | 1.04 | 28 | 13.0 | 15.37(28) | 1.48 | 188 | 15.54(07) | 0.97 | 15.54(07) | 0.91 |
| | 7 | 170 | 15.40(06) | 0.83 | 19 | 11.2 | 14.57(20) | 0.87 | 151 | 15.50(06) | 0.76 | 15.53(07) | 0.81 |
| | 10 | 223 | 15.55(06) | 0.96 | 37 | 16.6 | 15.29(19) | 1.16 | 186 | 15.60(07) | 0.91 | 15.66(07) | 0.92 |
| Mud Tank | 4 | 214 | 16.10(07) | 0.97 | 26 | 12.1 | 16.34(26) | 1.32 | 188 | 16.07(07) | 0.91 | 16.03(07) | 0.90 |
| | 8 | 210 | 16.01(07) | 1.06 | 22 | 10.5 | 14.97(28) | 1.33 | 188 | 16.13(07) | 0.96 | 16.08(07) | 0.89 |
| Renfrew | 3 | 202 | 15.33(09) | 1.32 | 28 | 13.9 | 15.02(33) | 1.76 | 174 | 15.38(09) | 1.24 | 15.32(07) | 1.17 |
| | 9 | 205 | 15.45(07) | 1.03 | 36 | 17.6 | 15.16(19) | 1.13 | 169 | 15.52(08) | 1.00 | 15.53(07) | 0.94 |
| King Island | 12 | 174 | 15.07(09) | 1.19 | 13 | 7.5 | 14.18(45) | 1.64 | 161 | 15.14(06) | 1.14 | 15.19(07) | 1.07 |
| | | <i>5.5M etch⁵</i> | | | | | | | | | | | |
| Durango | 1 | 188 | 15.83(05) | 0.73 | 29 | 15.4 | 15.78(15) | 0.79 | 159 | 15.90(06) | 0.71 | 15.84(06) | 0.72 |
| | 7 | 188 | 15.89(06) | 0.79 | 29 | 15.4 | 15.75(17) | 0.91 | 159 | 15.87(06) | 0.80 | 15.92(06) | 0.77 |
| | 10 | 200 | 16.05(05) | 0.70 | 31 | 15.5 | 15.96(14) | 0.80 | 169 | 16.15(05) | 0.71 | 16.06(05) | 0.68 |
| Mud Tank | 4 | 190 | 16.25(06) | 0.78 | 31 | 16.3 | 16.43(15) | 0.85 | 159 | 16.18(06) | 0.82 | 16.21(06) | 0.76 |
| | 8 | 201 | 16.33(05) | 0.70 | 29 | 14.4 | 16.27(15) | 0.79 | 172 | 16.34(05) | 0.71 | 16.34(05) | 0.68 |
| Renfrew | 3 | 196 | 15.62(05) | 0.73 | 26 | 13.3 | 15.49(15) | 0.75 | 170 | 15.63(06) | 0.74 | 15.64(06) | 0.73 |
| | 9 | 202 | 15.77(05) | 0.69 | 38 | 18.8 | 15.75(10) | 0.61 | 164 | 15.75(06) | 0.72 | 15.78(06) | 0.71 |
| King Island | 12 | 134 | 15.52(07) | 0.77 | 13 | 9.7 | 15.13(18) | 0.65 | 121 | 15.56(07) | 0.81 | 15.57(07) | 0.77 |

¹ Initial measurements of 5.0M etch by An1; initial measurements of 5.5M etch by An2.

² Subset of initial tracks rejected by the other analyst.

³ Subset of initial tracks accepted by both analysts.

⁴ Tracks etched using 5.0M HNO₃, located, imaged, and measured initially by An1; measurements repeated on the same images by An2.

⁵ Tracks etched using 5.5M HNO₃, located, imaged, and measured initially by An2; measurements repeated on the same images by An1.

Table 3: Difference between An1 and An2 Set 1 confined track measurements.

| Apatite | Sample | N | 2D MTL (μm) ¹ | StDev | 3D MTL (μm) ² | StDev | Dip ($^{\circ}$) | StDev | 3D c-ax ($^{\circ}$) ³ | StDev |
|------------------|--------|-----|--|-------|--|-------|-----------------------|-------|--|-------|
| <i>5.0M etch</i> | | | | | | | | | | |
| Durango | 1 | 188 | -0.01 | 0.43 | -0.02 | 0.45 | 0.01 | 2.89 | -0.15 | 1.08 |
| | 7 | 151 | 0.00 | 0.43 | -0.02 | 0.44 | -0.09 | 4.37 | -0.03 | 0.97 |
| | 10 | 186 | -0.08 | 0.50 | -0.06 | 0.51 | 0.73 | 2.64 | -0.03 | 1.10 |
| Mud Tank | 4 | 188 | 0.06 | 0.41 | 0.04 | 0.43 | -0.14 | 2.81 | 0.04 | 1.17 |
| | 8 | 188 | 0.02 | 0.38 | 0.05 | 0.38 | 0.93 | 3.03 | 0.07 | 1.12 |
| Renfrew | 3 | 174 | 0.03 | 0.37 | 0.05 | 0.37 | 0.68 | 3.27 | 0.02 | 1.09 |
| | 9 | 169 | -0.01 | 0.35 | -0.02 | 0.34 | 0.04 | 3.31 | 0.07 | 0.96 |
| King Island | 12 | 161 | -0.07 | 0.38 | -0.05 | 0.34 | 0.28 | 3.41 | -0.09 | 1.27 |
| <i>5.5M etch</i> | | | | | | | | | | |
| Durango | 1 | 159 | -0.06 | 0.21 | -0.05 | 0.25 | 0.22 | 2.70 | 0.06 | 0.88 |
| | 7 | 159 | 0.05 | 0.31 | 0.05 | 0.32 | -0.08 | 2.14 | -0.10 | 0.67 |
| | 10 | 169 | -0.09 | 0.27 | -0.09 | 0.28 | 0.21 | 2.38 | -0.02 | 0.57 |
| Mud Tank | 4 | 159 | 0.07 | 0.26 | 0.04 | 0.30 | -0.61 | 2.70 | -0.15 | 1.00 |
| | 8 | 172 | -0.01 | 0.22 | 0.00 | 0.23 | 0.10 | 2.54 | -0.10 | 0.69 |
| Renfrew | 3 | 170 | 0.04 | 0.23 | 0.01 | 0.25 | -0.82 | 2.86 | -0.19 | 0.98 |
| | 9 | 164 | 0.02 | 0.27 | 0.02 | 0.28 | -0.01 | 2.46 | 0.01 | 0.64 |
| King Island | 12 | 151 | 0.00 | 0.36 | -0.01 | 0.38 | 0.17 | 3.65 | -0.02 | 0.97 |

¹ Mean difference in mean confined track length without accounting for dip.

² Mean difference in 3D mean confined track length.

³ Mean difference in 3D angle to c-axis

Table 4: Etch figure measurements.

| Apatite | Sample | N | Analyst 1 | | Analyst 2 | |
|------------------------------|--------|----|------------------------|-------------------------|------------------------|-------------------------|
| | | | Dpar (μm) | StDev (μm) | Dpar (μm) | StDev (μm) |
| <i>5.0M etch¹</i> | | | | | | |
| Durango | 1 | 38 | 1.82(03) | 0.16 | 1.77(02) | 0.11 |
| | 7 | 44 | 1.75(02) | 0.14 | 1.79(02) | 0.11 |
| | 10 | 45 | 1.75(02) | 0.12 | 1.62(02) | 0.12 |
| Mud Tank | 4 | 44 | 2.18(04) | 0.28 | 1.99(04) | 0.26 |
| | 8 | 47 | 2.33(03) | 0.24 | 2.18(04) | 0.30 |
| Renfrew | 3 | 48 | 1.89(03) | 0.19 | 1.57(02) | 0.16 |
| | 9 | 47 | 1.67(02) | 0.16 | 1.48(02) | 0.14 |
| King Island | 12 | 45 | 1.39(02) | 0.12 | 1.30(02) | 0.13 |
| <i>5.5M etch²</i> | | | | | | |
| Durango | 1 | 50 | 1.78(02) | 0.13 | 1.75(02) | 0.11 |
| | 7 | 50 | 1.80(02) | 0.16 | 1.78(02) | 0.11 |
| | 10 | 40 | 1.77(02) | 0.14 | 1.77(02) | 0.15 |
| Mud Tank | 4 | 50 | 2.20(04) | 0.30 | 2.05(03) | 0.08 |
| | 8 | 50 | 2.42(03) | 0.22 | 2.27(04) | 0.25 |
| Renfrew | 3 | 42 | 1.55(03) | 0.18 | 1.45(02) | 0.15 |
| | 9 | 50 | 1.48(02) | 0.14 | 1.48(02) | 0.17 |
| King Island | 12 | 50 | 1.42(02) | 0.17 | 1.37(02) | 0.17 |

¹ Samples etched using 5.0M HNO₃, and etch figures located, imaged, and measured initially by An1; measurements repeated on the same images by An2.

² Samples etched using 5.5M HNO₃, and etch figures located, imaged, and measured initially by An2; measurements repeated on the same images by An1.

Table 5: Set 2 confined track length measurements, switching the analyst locating tracks from Set 1.

| Apatite Species | Sample | Analyst 1 (5.5M) | | | Analyst 2 (5.0M) | | |
|-----------------|--------|------------------|-----------------------|-------------------------|------------------|-----------------------|-------------------------|
| | | N | MTL (μm) | StDev (μm) | N | MTL (μm) | StDev (μm) |
| Durango | 1 | 131 | 15.84(07) | 0.76 | 97 | 15.47(11) | 1.12 |
| | 7 | 108 | 15.90(07) | 0.77 | 99 | 15.14(09) | 0.92 |
| | 10 | 134 | 15.95(06) | 0.68 | 223 | 15.48(07) | 1.06 |
| Mud Tank | 4 | 110 | 16.32(08) | 0.87 | 94 | 16.03(08) | 0.74 |
| | 8 | 109 | 16.30(08) | 0.87 | 97 | 16.00(08) | 0.77 |
| Renfrew | 3 | 111 | 15.66(08) | 0.80 | 94 | 15.00(11) | 1.04 |
| | 9 | 111 | 15.79(08) | 0.84 | 94 | 15.17(10) | 0.97 |
| King Island | 12 | 107 | 15.60(07) | 0.76 | 97 | 15.13(12) | 1.15 |

Table 6: Confined track length measurements after 5s additional etching.

| Apatite | Sample | 20s | | | 20+5s | | |
|----------|--------|------------------|-----------------------|-------------------------|-------|-----------------------|-------------------------|
| | | N | MTL (μm) | StDev (μm) | N | MTL (μm) | StDev (μm) |
| | | <i>5.0M etch</i> | | | | | |
| Renfrew | 3 | 174 | 15.38(09) | 1.24 | 143 | 16.20(08) | 0.99 |
| Mud Tank | 4 | 188 | 16.07(07) | 0.91 | 146 | 16.72(07) | 0.84 |
| Durango | 10 | 186 | 15.60(07) | 0.91 | 138 | 16.17(07) | 0.84 |
| | | <i>5.5M etch</i> | | | | | |
| Renfrew | 3 | 170 | 15.64(06) | 0.73 | 128 | 16.02(06) | 0.71 |
| Mud Tank | 4 | 159 | 16.21(06) | 0.76 | 117 | 16.61(07) | 0.72 |
| Durango | 10 | 169 | 16.06(05) | 0.68 | 116 | 16.50(06) | 0.67 |

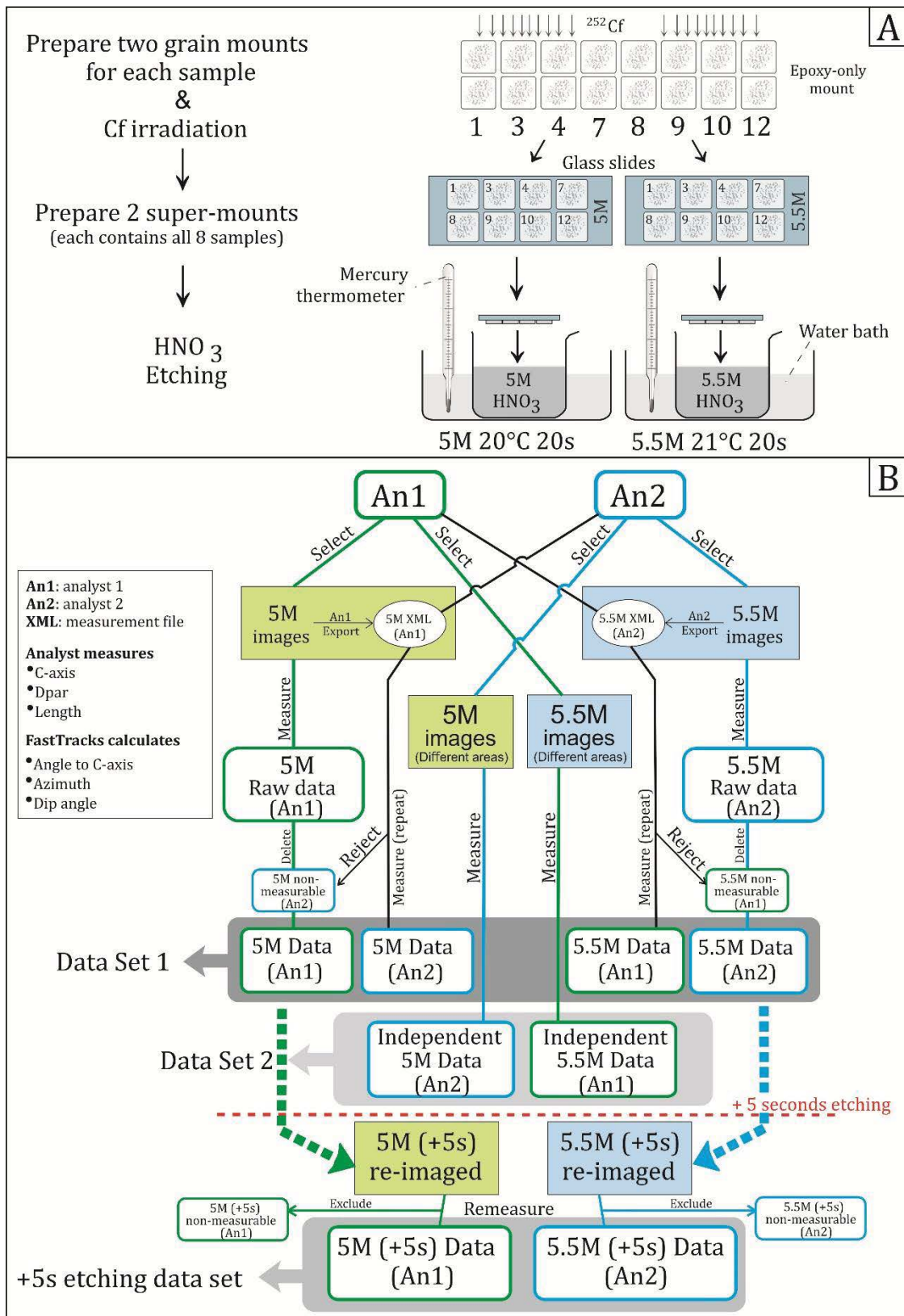


Figure 1: Experimental design of the study in etching (A) and measurement, track selection and re-etching procedures (B).

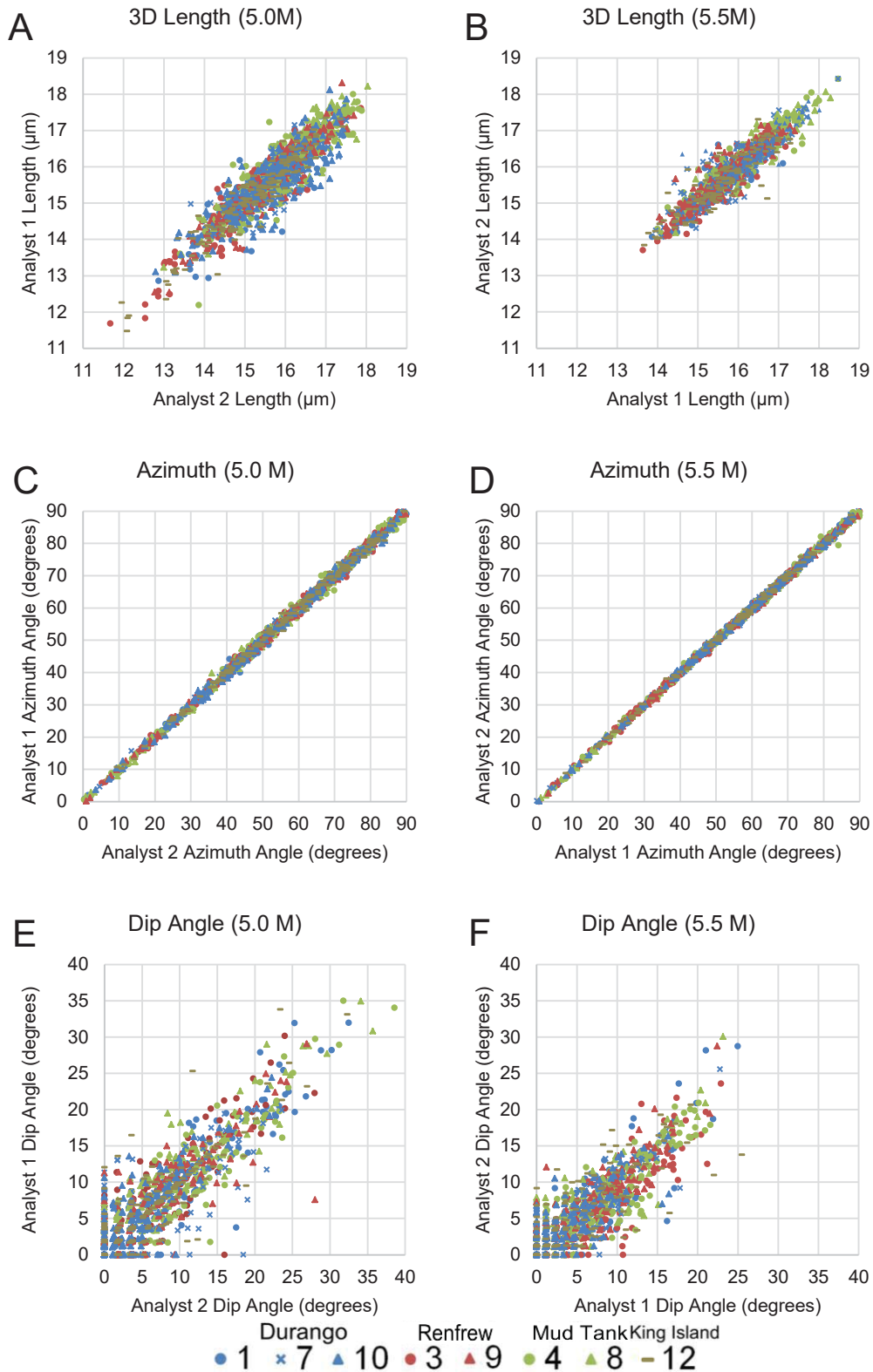


Figure 2: Comparison of the single individual confined track length measurements for two analysts with 5.0M (A, C, E) and 5.5M (B, D, F) protocols.

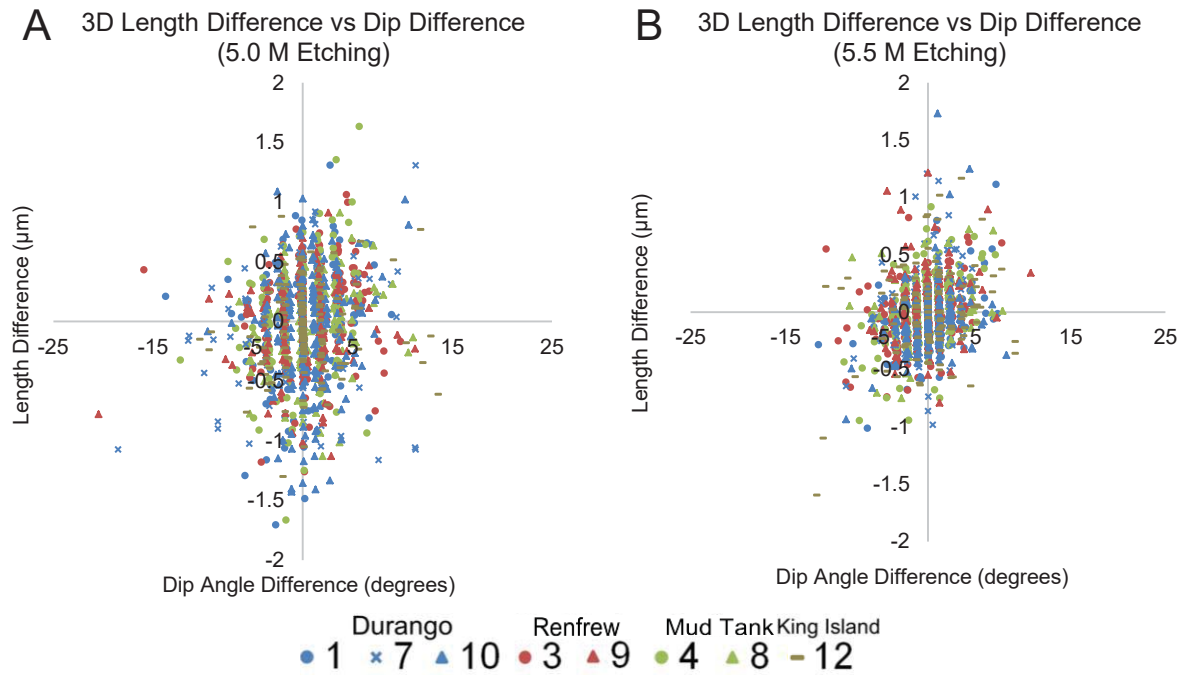


Figure 3: Relationship between the track length and dip angle difference in 5.0M (A) and 5.5 M (B).

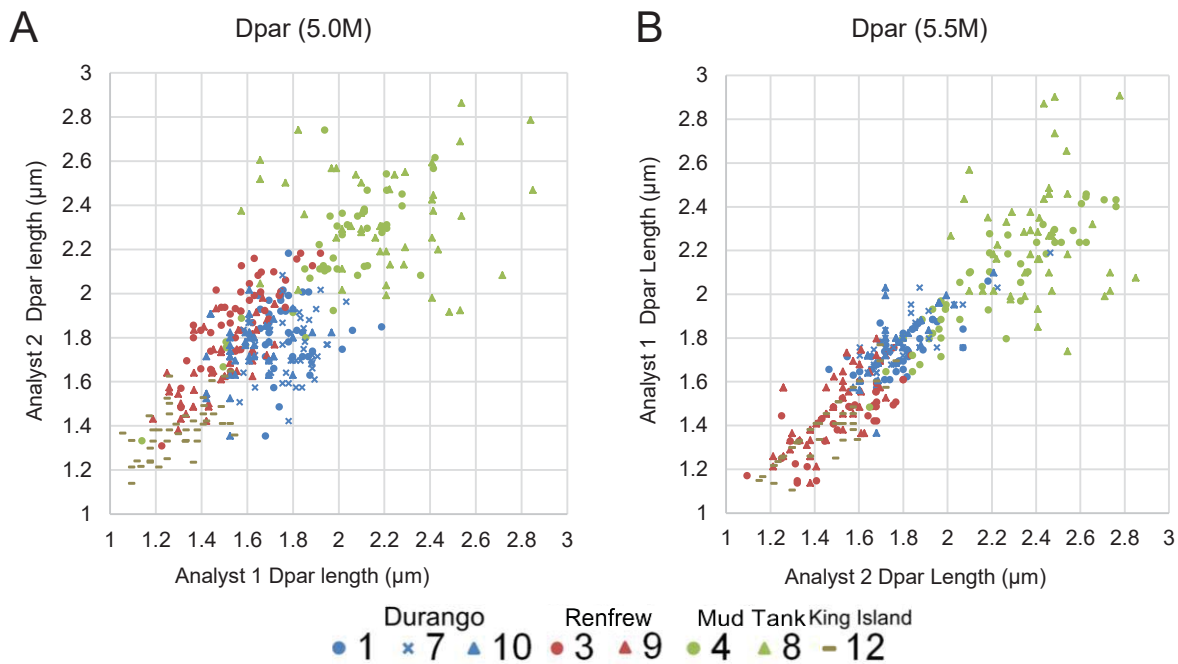


Figure 4: Comparison of individual Dpar measurements by each analyst with 5.0M (A) and 5.5 M (B) protocols.

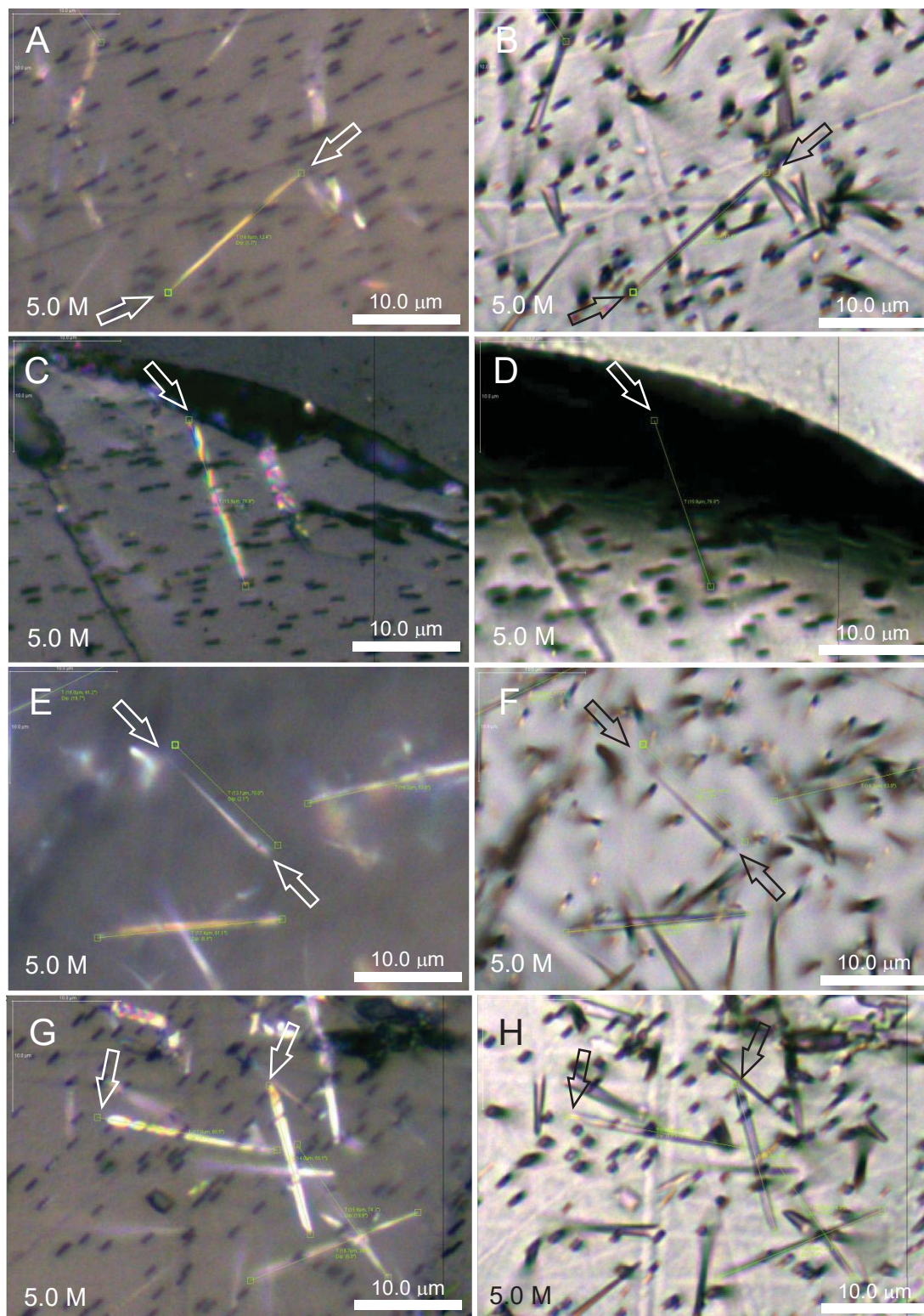


Figure 5: Reflected (left) and transmitted (right) light images of confined tracks found and measured by An1 and rejected by An2. Arrows indicate the features responsible for rejection. In A the track ends are arguably ambiguous, and in B they are obscured by other features. C and D show a track that is not unambiguously confined on both ends in reflected light, while in transmitted light

half of the track is not visible. E and F show a track with indistinct ends. There are two rejections in G and H. The right track ends are distinct under reflected light but blurry under transmitted. The left track appears to intersect the surface.

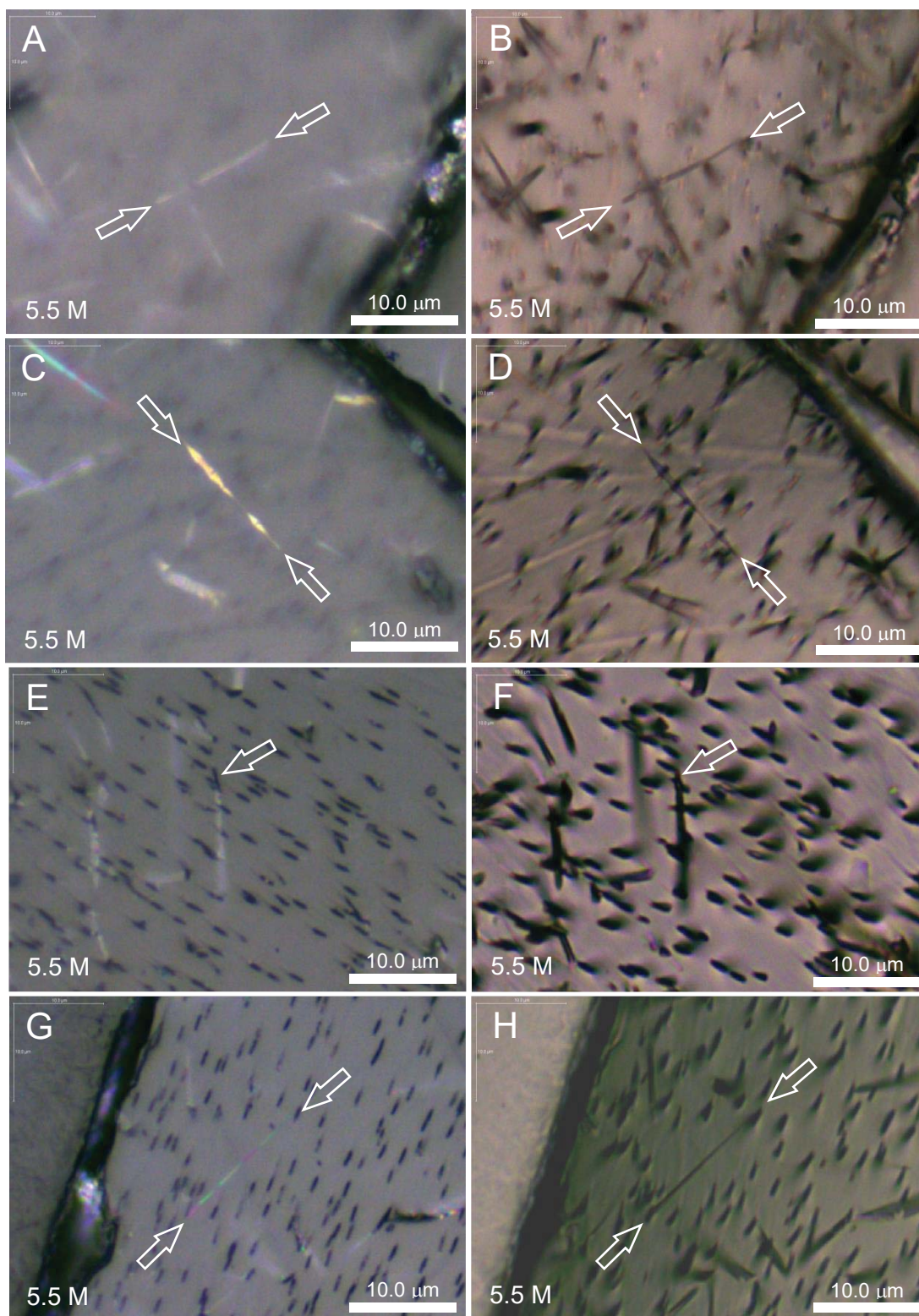


Figure 6: Reflected (left) and transmitted (right) light images of confined tracks found and measured by An2 and rejected by An 1. Arrows indicate the features responsible for rejection. Track ends in A and B are ambiguous. The track in Figure 5C and 5D was judged as under-etched

and thus cannot be measured confidently. Figure 5E and 5F show a track that appears to be a confined track under transmitted light but has a clear surface intersection under reflected light. Figure 5G and 5H show a confined track where both ends are obscured by other features under transmitted light and one end (top-right) is still difficult to determine using reflected light.

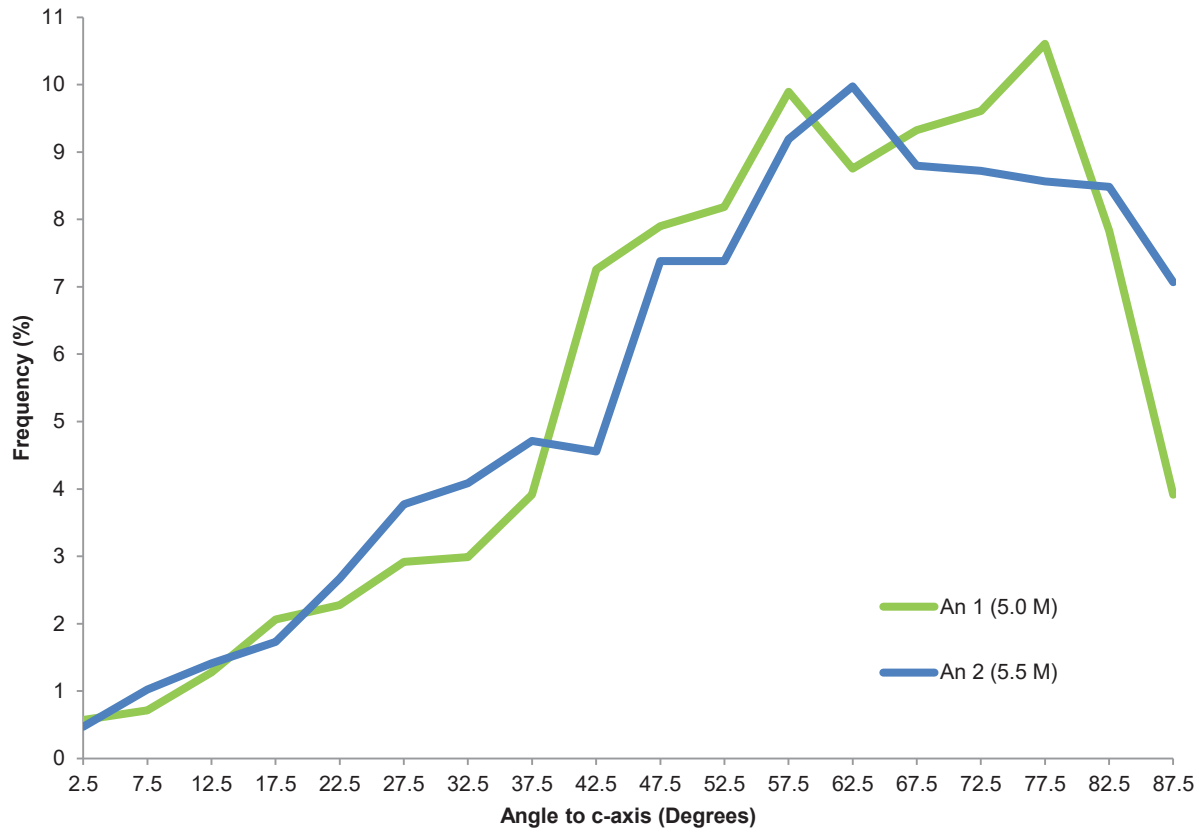


Figure 7: Comparison of the distribution of the c-axis angles of confined tracks in Set 1 measurements by the two analysts. All tracks represented in this plot were also evaluated and accepted by the non-finding analyst, and so variations reflect differences in the initial scanning and evaluation process.

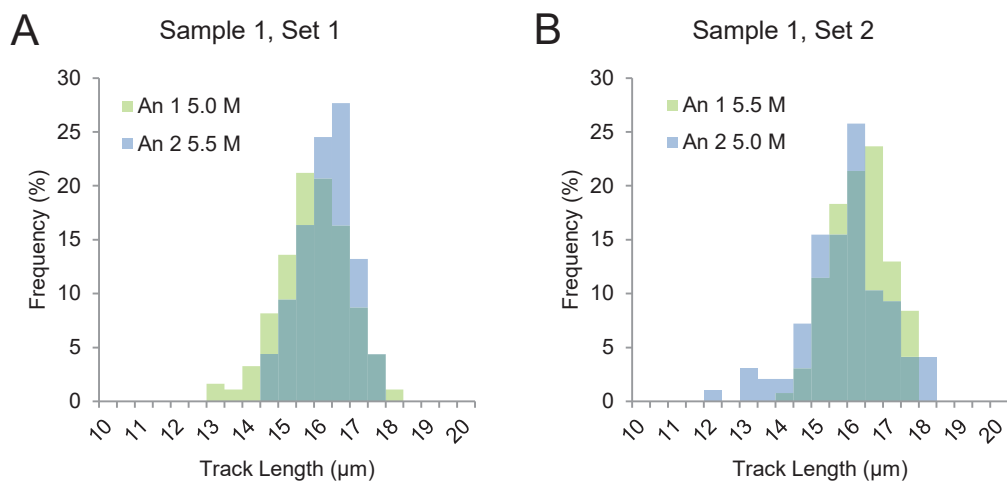


Figure 8: Histograms of confined fission-track lengths in Sample 1 located by both analysts using both etching procedures. According to both analysts, the 5.5M etch produced a slightly longer mean track length (15.90 and 15.84 μm in A and B, respectively), and lower standard deviation (0.71 and 0.76 μm), than the 5.0M etch (15.52, 0.95 and 15.47, 1.12 μm), showing that the differences are due to the etchant, and not the analyst.

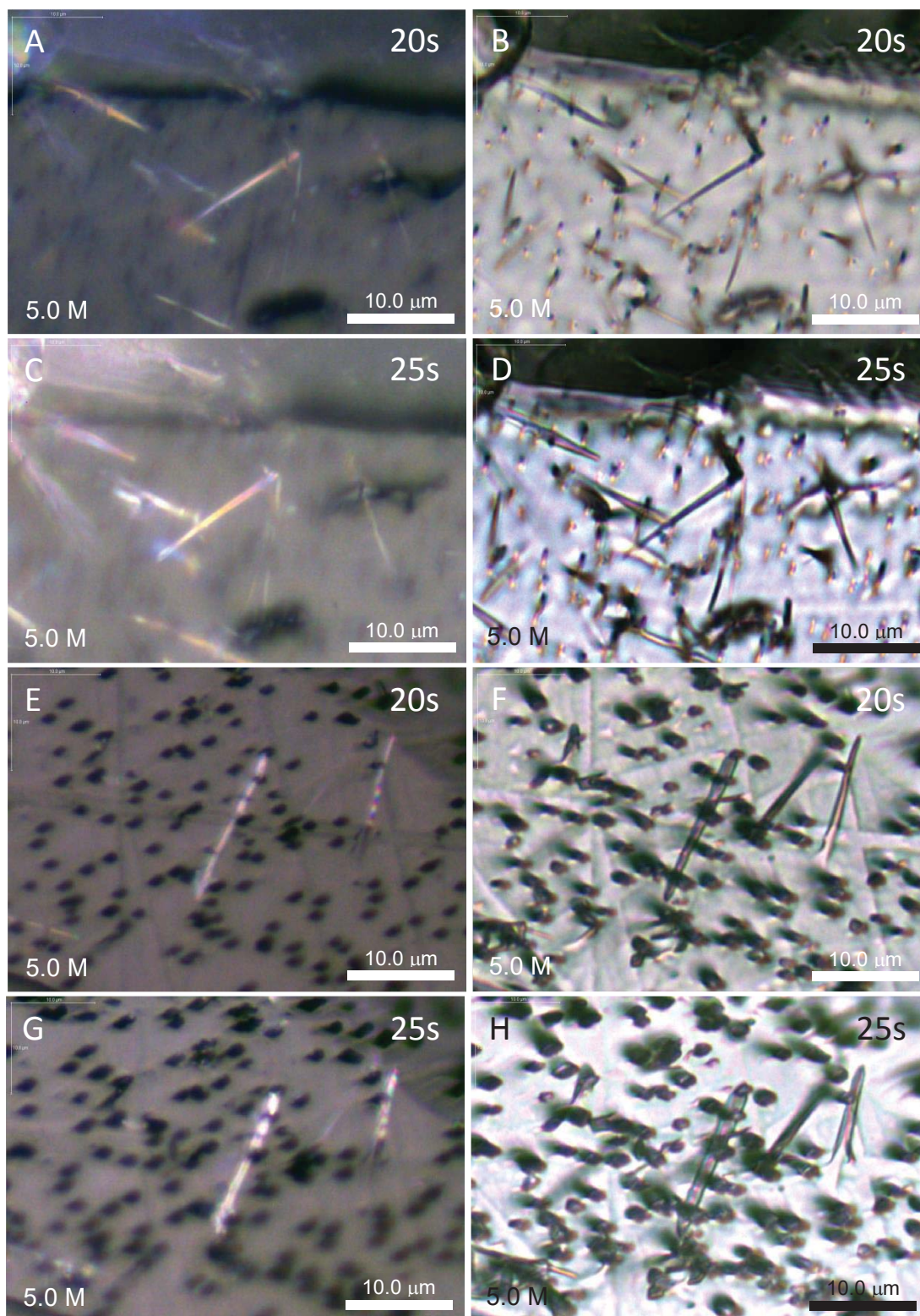


Figure 9: Images of two confined tracks in reflected (left) and transmitted (right) light at 20s (A,B) and 25s (C,D) etching in Durango apatite and 20s (E,F) and 25s (G,H) etching in Mud Tank apatite, both with the 5.0M protocol.

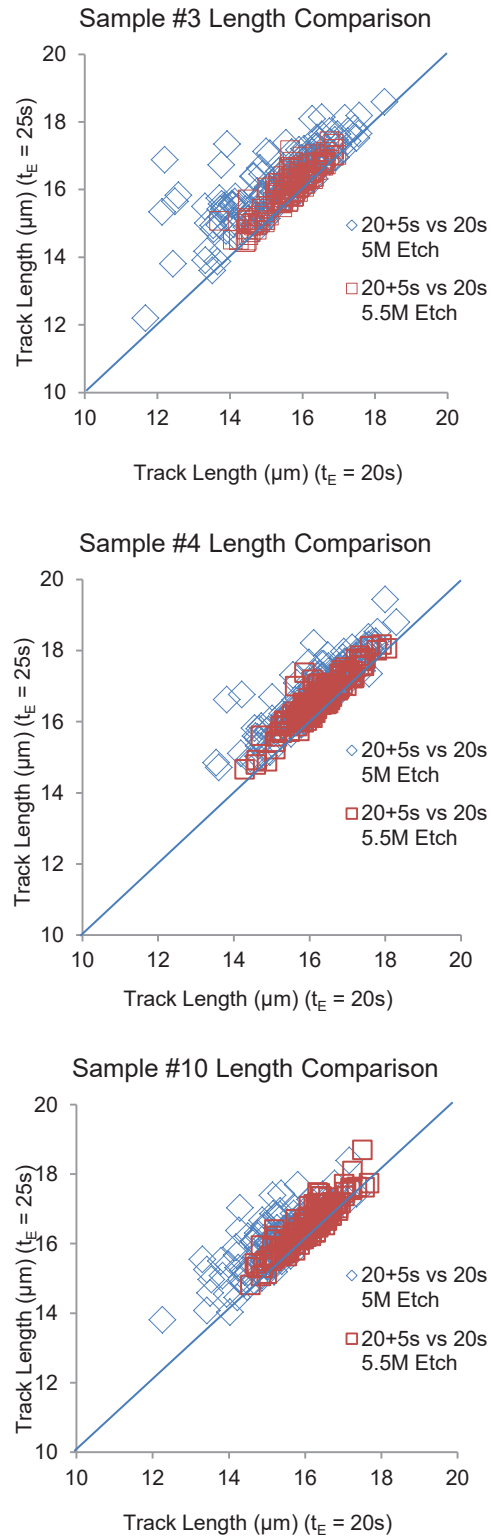


Figure 10: Comparison of 20s against 25s step-etch data on individual track lengths in three samples with both etching protocols; 5.0 M in blue, 5.5 M in red. The blue reference line shows the 1:1 relation.

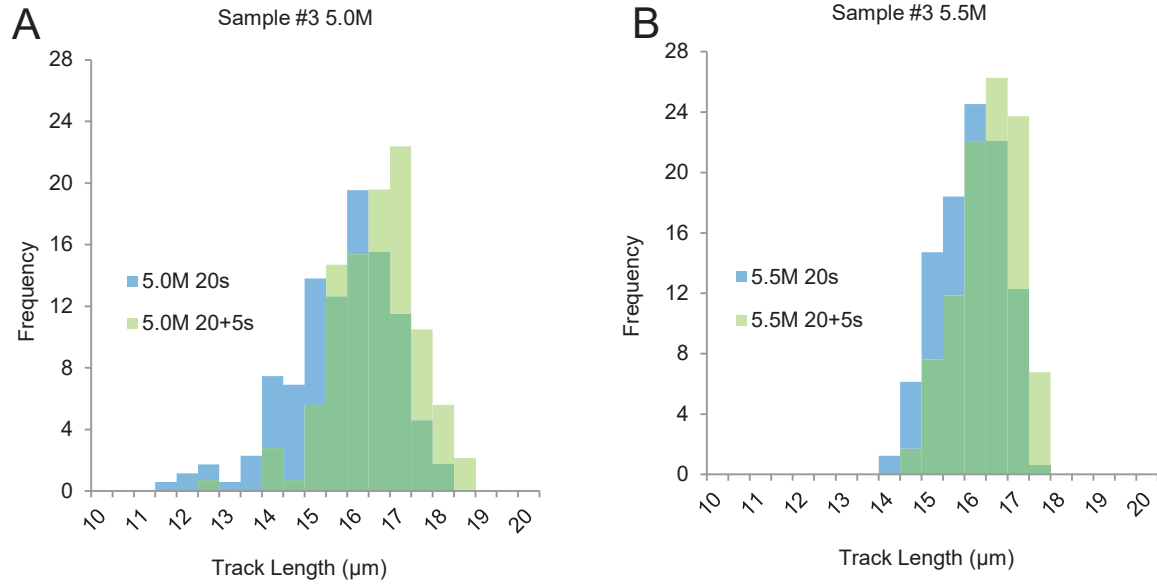


Figure 11: Confined track length distributions after 20 and 25 seconds of etching time using 5.0M (A) and 5.5M (B) etchants at 20°C.

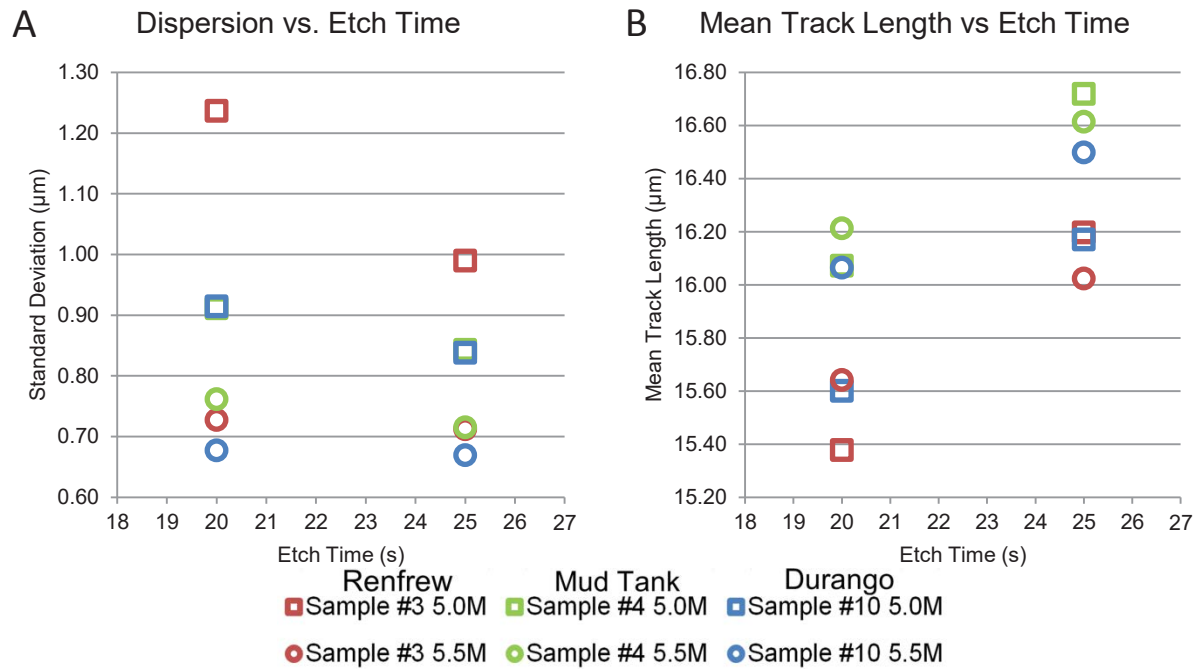


Figure 12: Standard deviation (A) and mean lengths (B) of confined fission tracks vs. etching time. Error bars are omitted for clarity.

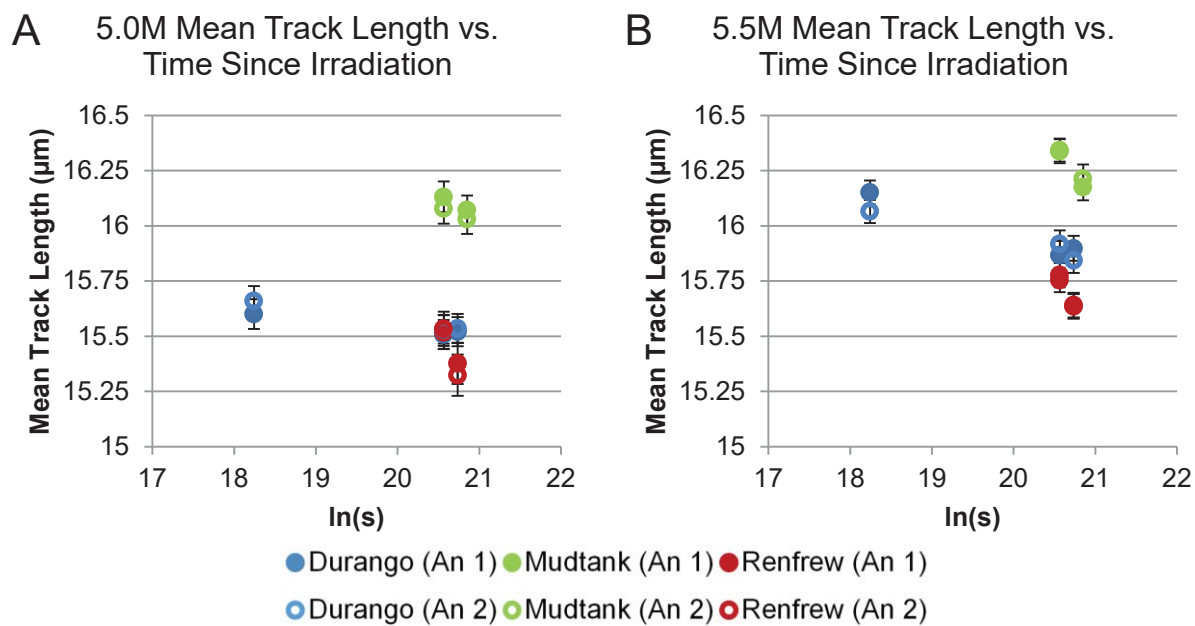


Figure 13: Changes in mean induced track lengths according to time that samples experienced ambient temperatures ($\sim 20^{\circ}\text{C}$) after irradiation and prior to etching using 5.0M (A) and 5.5M (B) protocols. Error bars are one standard error.

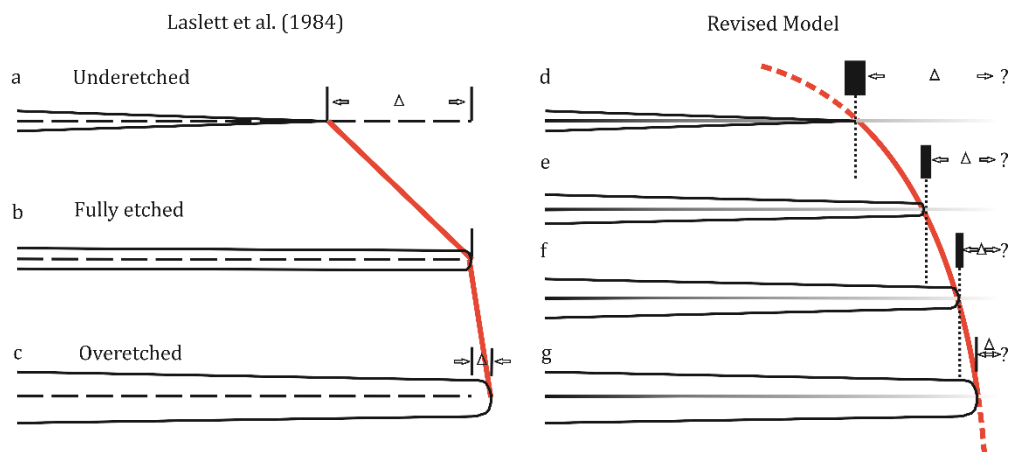


Figure 14: Track etching model from Laslett et al. (1984) and proposed revised model. The Laslett et al. (1984) model is built upon the assumption of a constant etch rate along the latent track, indicated by dashed line, while in the revised model the track etching rate changes along the track, with lighter shades of gray indicating slower etching, approaching the bulk etching rate. The black boxes symbolize the measurement precision. The delta symbols indicate distance from the etched track to the “true” track end; the question marks denote that this quantity is not straightforward to define due to the gradual reduction in etch rate.